Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,207	CHAN, ALBERT	
Examiner	Art Unit	
John I. Goff	1733	

SEARCHED					
Class	Subclass	Date	Examiner		
156	276,307.7	10/25/2005	JLG		
252	519.31	10/25/2005	JLG		
252	519.33	10/25/2005	JLG		
252	520.1	10/25/2005	JLG		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
]			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	10/25/2005	JLG		
Inventor Search - PALM	10/25/2005	JLG		
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